May 4, 2006

# FSAM50SM60A

# FAIRCHILD

SEMICONDUCTOR®

# FSAM50SM60A

## SPM<sup>™</sup> (Smart Power Module)

### **General Description**

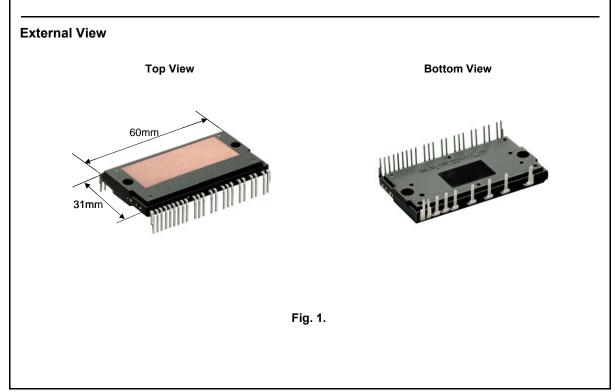
FSAM50SM60A is an advanced smart power module (SPM) that Fairchild has newly developed and designed to provide very compact and low cost, yet high performance ac motor drives mainly targeting medium speed low-power inverter-driven application like air conditioners. It combines optimized circuit protection and drive matched to low-loss IGBTs. Highly effective short-circuit current detection/ protection is realized through the use of advanced current sensing IGBT chips that allow continuous monitoring of the IGBTs current. System reliability is further enhanced by the built-in over-temperature and integrated under-voltage lock-out protection. The high speed built-in HVIC provides opto-coupler-less IGBT gate driving capability that further reduce the overall size of the inverter system design. In addition the incorporated HVIC facilitates the use of singlesupply drive topology enabling the FSAM50SM60A to be driven by only one drive supply voltage without negative bias. Inverter current sensing application can be achieved due to the devided nagative dc terminals.

### Features

- UL Certified No. E209204
- 600V-50A 3-phase IGBT inverter bridge including control ICs for gate driving and protection
- Divided negative dc-link terminals for inverter current sensing applications
- Single-grounded power supply due to built-in HVIC
- Typical switching frequency of 5kHz
- Built-in thermistor for over-temperature monitoring
- Isolation rating of 2500Vrms/min.
- Very low leakage current due to using DBC (Direct Bonded Copper) substrate
- Adjustable current protection level by varying series resistor value with sense-IGBTs

### Applications

- AC 100V ~ 253V three-phase inverter drive for small power ac motor drives
- Home appliances applications like air conditioners drive system



# FSAM50SM60A

### **Integrated Power Functions**

• 600V-50A IGBT inverter for three-phase DC/AC power conversion (Please refer to Fig. 3)

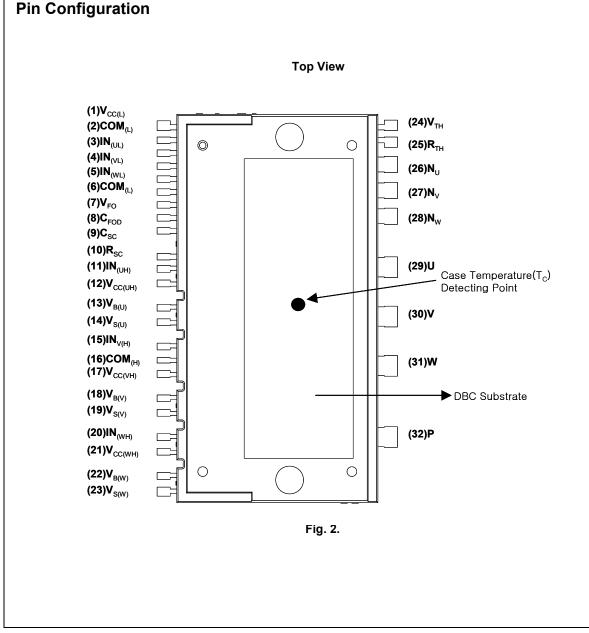
## Integrated Drive, Protection and System Control Functions

• For inverter high-side IGBTs: Gate drive circuit, High voltage isolated high-speed level shifting

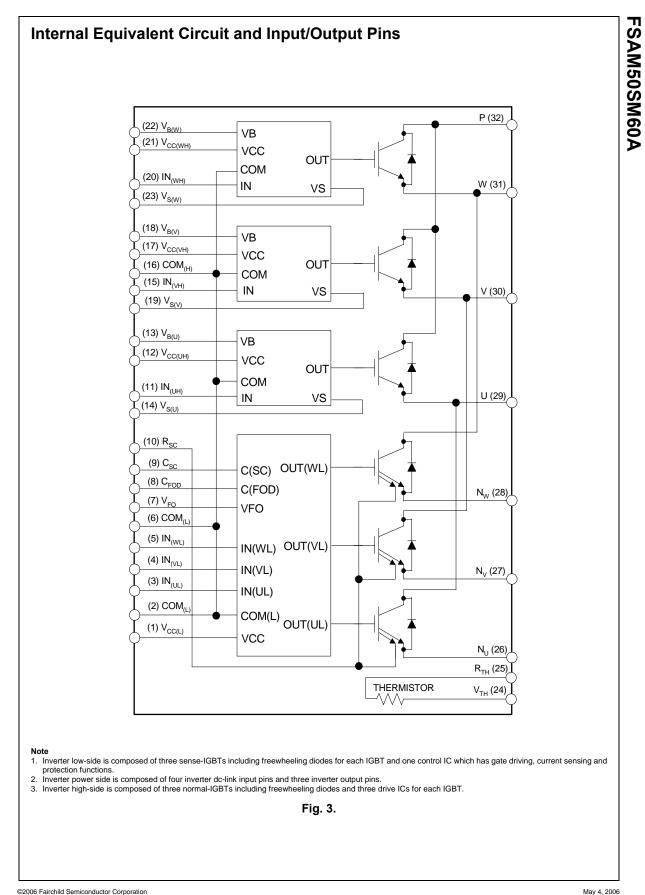
Control circuit under-voltage (UV) protection

Note) Available bootstrap circuit example is given in Figs. 13 and 14.

- For inverter low-side IGBTs: Gate drive circuit, Short circuit protection (SC)
  - Control supply circuit under-voltage (UV) protection
- Temperature Monitoring: System over-temperature monitoring using built-in thermistor
  - Note) Available temperature monitoring circuit is given in Fig. 14.
- Fault signaling: Corresponding to a SC fault (Low-side IGBTs) or a UV fault (Low-side control supply circuit)
- Input interface: 5V CMOS/LSTTL compatible, Schmitt trigger input



| in Number | Pin Name            | Pin Description   |
|-----------|---------------------|---|
| 1         | V <sub>CC(L)</sub>  | Low-side Common Bias Voltage for IC and IGBTs Driving                 |
| 2         | COM <sub>(L)</sub>  | Low-side Common Supply Ground   |
| 3         | IN <sub>(UL)</sub>  | Signal Input Terminal for Low-side U Phase                            |
| 4         | IN <sub>(VL)</sub>  | Signal Input Terminal for Low-side V Phase                            |
| 5         | IN <sub>(WL)</sub>  | Signal Input Terminal for Low-side W Phase                            |
| 6         | COM <sub>(L)</sub>  | Low-side Common Supply Ground   |
| 7         | V <sub>FO</sub>     | Fault Output  |
| 8         | C <sub>FOD</sub>    | Capacitor for Fault Output Duration Time Selection                    |
| 9         | C <sub>SC</sub>     | Capacitor (Low-pass Filter) for Short-Circuit Current Detection Input |
| 10        | R <sub>SC</sub>     | Resistor for Short-circuit Current Detection                          |
| 11        | IN <sub>(UH)</sub>  | Signal Input for High-side U Phase                                    |
| 12        | V <sub>CC(UH)</sub> | High-side Bias Voltage for U Phase IC                                 |
| 13        | V <sub>B(U)</sub>   | High-side Bias Voltage for U Phase IGBT Driving                       |
| 14        | V <sub>S(U)</sub>   | High-side Bias Voltage Ground for U Phase IGBT Driving                |
| 15        | IN <sub>(VH)</sub>  | Signal Input for High-side V Phase                                    |
| 16        | COM <sub>(H)</sub>  | High-side Common Supply Ground  |
| 17        | V <sub>CC(VH)</sub> | High-side Bias Voltage for V Phase IC                                 |
| 18        | V <sub>B(V)</sub>   | High-side Bias Voltage for V Phase IGBT Driving                       |
| 19        | V <sub>S(V)</sub>   | High-side Bias Voltage Ground for V Phase IGBT Driving                |
| 20        | IN <sub>(WH)</sub>  | Signal Input for High-side W Phase                                    |
| 21        | V <sub>CC(WH)</sub> | High-side Bias Voltage for W Phase IC                                 |
| 22        | V <sub>B(W)</sub>   | High-side Bias Voltage for W Phase IGBT Driving                       |
| 23        | V <sub>S(W)</sub>   | High-side Bias Voltage Ground for W Phase IGBT Driving                |
| 24        | V <sub>TH</sub>     | Thermistor Bias Voltage   |
| 25        | R <sub>TH</sub>     | Series Resistor for the Use of Thermistor (Temperature Detection)     |
| 26        | NU                  | Negative DC–Link Input Terminal for U Phase                           |
| 27        | N <sub>V</sub>      | Negative DC–Link Input Terminal for V Phase                           |
| 28        | N <sub>W</sub>      | Negative DC-Link Input Terminal for W Phase                           |
| 29        | U                   | Output for U Phase  |
| 30        | V                   | Output for V Phase  |
| 31        | W                   | Output for W Phase  |
| 32        | Р                   | Positive DC–Link Input  |



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# Absolute Maximum Ratings ( $T_J = 25^{\circ}C$ , Unless Otherwise Specified) **Inverter Part**

| ltem                               | Symbol                 | Condition                                     | Rating    | Unit |
|------------------------------------|------------------------|---|-----------|------|
| Supply Voltage                     | V <sub>DC</sub>        | Applied to DC - Link                          | 450       | V    |
| Supply Voltage (Surge)             | V <sub>PN(Surge)</sub> | Applied between P- N                          | 500       | V    |
| Collector-emitter Voltage          | V <sub>CES</sub>       |   | 600       | V    |
| Each IGBT Collector Current        | ± I <sub>C</sub>       | $T_{\rm C} = 25^{\circ}{\rm C}$               | 50        | Α    |
| Each IGBT Collector Current        | ± I <sub>C</sub>       | $T_{\rm C} = 100^{\circ}{\rm C}$              | 25        | Α    |
| Each IGBT Collector Current (Peak) | ± I <sub>CP</sub>      | $T_{C} = 25^{\circ}C$ , Under 1ms pulse width | 100       | Α    |
| Collector Dissipation              | P <sub>C</sub>         | T <sub>C</sub> = 25°C per One Chip            | 100       | W    |
| Operating Junction Temperature     | ТJ                     | (Note 1)                                      | -20 ~ 125 | °C   |

Note 1. It would be recommended that the average junction temperature should be limited to  $T_J \le 125^{\circ}C$  (@ $T_C \le 100^{\circ}C$ ) in order to guarantee safe operation.

### **Control Part**

| ltem                           | Symbol          | Condition   | Rating                      | Unit |
|--------------------------------|-----------------|---|-----------------------------|------|
| Control Supply Voltage         | V <sub>CC</sub> | Applied between $V_{CC(UH)}$ , $V_{CC(VH)}$ , $V_{CC(WH)}$ - $COM_{(H)}$ , $V_{CC(L)}$ - $COM_{(L)}$  | 20                          | V    |
| High-side Control Bias Voltage | $V_{BS}$        | Applied between V <sub>B(U)</sub> - V <sub>S(U)</sub> , V <sub>B(V)</sub> - V <sub>S(V)</sub> , V <sub>B(W)</sub> - V <sub>S(W)</sub>   | 20                          | V    |
| Input Signal Voltage           | V <sub>IN</sub> | $ \begin{array}{l} \mbox{Applied between IN}_{(UH)}, \mbox{IN}_{(VH)}, \mbox{IN}_{(WH)} \mbox{-} \mbox{COM}_{(H)} \\ \mbox{IN}_{(UL)}, \mbox{IN}_{(VL)}, \mbox{IN}_{(WL)} \mbox{-} \mbox{COM}_{(L)} \end{array} $ | -0.3 ~ V <sub>CC</sub> +0.3 | V    |
| Fault Output Supply Voltage    | V <sub>FO</sub> | Applied between V <sub>FO</sub> - COM <sub>(L)</sub>  | -0.3 ~ V <sub>CC</sub> +0.3 | V    |
| Fault Output Current           | I <sub>FO</sub> | Sink Current at V <sub>FO</sub> Pin   | 5                           | mA   |
| Current Sensing Input Voltage  | V <sub>SC</sub> | Applied between C <sub>SC</sub> - COM <sub>(L)</sub>  | -0.3 ~ V <sub>CC</sub> +0.3 | V    |

## **Total System**

| Item  | Symbol                | Condition  | Rating    | Unit             |
|---|-----------------------|--|-----------|------------------|
| Self Protection Supply Voltage Limit<br>(Short Circuit Protection Capability) | V <sub>PN(PROT)</sub> | Applied to DC - Link,<br>$V_{CC} = V_{BS} = 13.5 \sim 16.5V$<br>$T_J = 125^{\circ}C$ , Non-repetitive, less than 5µs | 400       | V                |
| Module Case Operation Temperature   | Т <sub>С</sub>        | Note Fig. 2  | -20 ~ 100 | °C               |
| Storage Temperature   | T <sub>STG</sub>      |  | -20 ~ 125 | °C               |
| Isolation Voltage   | V <sub>ISO</sub>      | 60Hz, Sinusoidal, AC 1 minute, Connection<br>Pins to Heat-sink Plate   | 2500      | V <sub>rms</sub> |

# **Absolute Maximum Ratings**

### **Thermal Resistance**

| ltem                     | Symbol                | Condition                           | Min. | Тур. | Max. | Unit |
|--------------------------|-----------------------|-------------------------------------|------|------|------|------|
| Junction to Case Thermal | R <sub>th(j-c)Q</sub> | Inverter IGBT part (per 1/6 module) | -    | -    | 1.0  | °C/W |
| Resistance               | R <sub>th(j-c)F</sub> | Inverter FWDi part (per 1/6 module) | -    | -    | 1.5  | °C/W |
| Contact Thermal          | R <sub>th(c-f)</sub>  | Ceramic Substrate (per 1 Module)    | -    | -    | 0.06 | °C/W |
| Resistance               | . ,                   | Thermal Grease Applied (Note 3)     |      |      |      |      |

 $\begin{array}{l} \textbf{Note} \\ \textbf{2. For the measurement point of case temperature(T_C), please refer to Fig. 2. \\ \textbf{3. The thickness of thermal grease should not be more than 100um.} \end{array}$ 

# Package Marking and Ordering Information

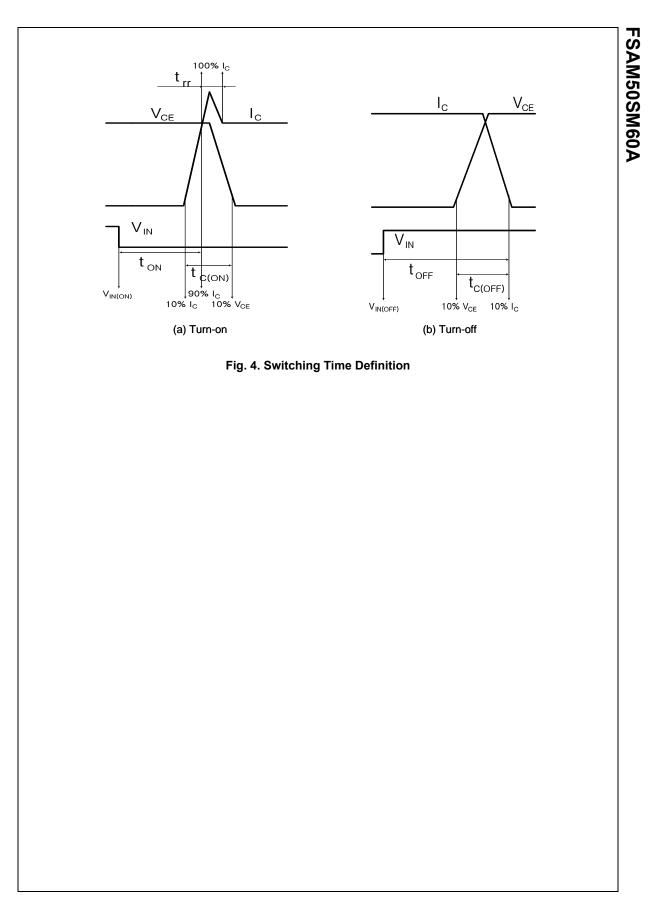
| Device Marking | Device      | Package  | Real Size | Tape Width | Quantity |
|----------------|-------------|----------|-----------|------------|----------|
| FSAM50SM60A    | FSAM50SM60A | SPM32-CA | -         | -          | 8        |

# **Electrical Characteristics**

Inverter Part (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

| ltem                                      | Symbol               | Condition  | on                                 | Min. | Тур. | Max. | Unit |
|---|----------------------|--|------------------------------------|------|------|------|------|
| Collector - emitter<br>Saturation Voltage | V <sub>CE(SAT)</sub> | $V_{CC} = V_{BS} = 15V$<br>$V_{IN} = 0V$                       | $I_{C} = 50A, T_{J} = 25^{\circ}C$ | -    | -    | 2.4  | V    |
| FWDi Forward Voltage                      | V <sub>FM</sub>      | V <sub>IN</sub> = 5V   | $I_{C} = 50A, T_{J} = 25^{\circ}C$ | -    | -    | 2.1  | V    |
| Switching Times                           | t <sub>ON</sub>      | V <sub>PN</sub> = 300V, V <sub>CC</sub> = V <sub>BS</sub> = 15 | V                                  | -    | 0.69 | -    | μs   |
|   | t <sub>C(ON)</sub>   | $I_{\rm C} = 50$ A, $T_{\rm J} = 25^{\circ}$ C                 |                                    | -    | 0.32 | -    | μs   |
|   | t <sub>OFF</sub>     | $V_{IN} = 5V \leftrightarrow 0V$ , Inductive Lo                | ad                                 | -    | 1.32 | -    | μs   |
|   | t <sub>C(OFF)</sub>  | (High-Low Side)  |                                    | -    | 0.46 | -    | μs   |
|   | t <sub>rr</sub>      | (Note 4)   |                                    | -    | 0.10 | -    | μs   |
| Collector - emitter<br>Leakage Current    | I <sub>CES</sub>     | $V_{CE} = V_{CES}, T_J = 25^{\circ}C$                          |                                    | -    | -    | 250  | μA   |

Note
4. t<sub>ON</sub> and t<sub>OFF</sub> include the propagation delay time of the internal drive IC. t<sub>C(ON)</sub> and t<sub>C(OFF)</sub> are the switching time of IGBT itself under the given gate driving condition internally. For the detailed information, please see Fig. 4.



| ltem                                     | Symbol               |  | Condition   | Min. | Тур. | Max. | Unit |
|--|----------------------|--|---|------|------|------|------|
| Quiescent V <sub>CC</sub> Supply Current | I <sub>QCCL</sub>    | V <sub>CC</sub> = 15V<br>IN <sub>(UL, VL, WL)</sub> = 5V | V <sub>CC(L)</sub> - COM <sub>(L)</sub>                         | -    | -    | 26   | mA   |
|  | I <sub>QCCH</sub>    | V <sub>CC</sub> = 15V<br>IN <sub>(UH, VH, WH)</sub> = 5V | $V_{CC(UH)}, V_{CC(VH)}, V_{CC(WH)} - COM_{(H)}$                | -    | -    | 130  | uA   |
| Quiescent V <sub>BS</sub> Supply Current | I <sub>QBS</sub>     | V <sub>BS</sub> = 15V<br>IN <sub>(UH, VH, WH)</sub> = 5V | $V_{B(U)} - V_{S(U)}, V_{B(V)} - V_{S(V)}, V_{B(W)} - V_{S(W)}$ | -    | -    | 420  | uA   |
| Fault Output Voltage                     | V <sub>FOH</sub>     | V <sub>SC</sub> = 0V, V <sub>FO</sub> Circuit            | t: 4.7k $\Omega$ to 5V Pull-up                                  | 4.5  | -    | -    | V    |
|  | V <sub>FOL</sub>     | V <sub>SC</sub> = 1V, V <sub>FO</sub> Circuit            | t: 4.7k $\Omega$ to 5V Pull-up                                  | -    | -    | 1.1  | V    |
| Short-Circuit Trip Level                 | V <sub>SC(ref)</sub> | V <sub>CC</sub> = 15V (Note 5)                           |   | 0.45 | 0.51 | 0.56 | V    |
| Sensing Voltage<br>of IGBT Current       | V <sub>SEN</sub>     | $R_{SC} = 40 \Omega, R_{SU} = F$<br>(Fig. 6)             | $R_{SV} = R_{SW} = 0 \ \Omega$ and $I_C = 75A$                  | 0.45 | 0.51 | 0.56 | V    |
| Supply Circuit Under-                    | UV <sub>CCD</sub>    | Detection Level  |   | 11.5 | 12   | 12.5 | V    |
| Voltage Protection                       | UV <sub>CCR</sub>    | Reset Level  |   | 12   | 12.5 | 13   | V    |
|  | UV <sub>BSD</sub>    | Detection Level  |   | 7.3  | 9.0  | 10.8 | V    |
|  | UV <sub>BSR</sub>    | Reset Level  |   | 8.6  | 10.3 | 12   | V    |
| Fault Output Pulse Width                 | t <sub>FOD</sub>     | C <sub>FOD</sub> = 33nF (Note 6                          |   | 1.4  | 1.8  | 2.0  | ms   |
| ON Threshold Voltage                     | V <sub>IN(ON)</sub>  | High-Side  | Applied between IN(UH), IN(VH),                                 | -    | -    | 0.8  | V    |
| OFF Threshold Voltage                    | V <sub>IN(OFF)</sub> |  | IN <sub>(WH)</sub> - COM <sub>(H)</sub>                         | 3.0  | -    | -    | V    |
| ON Threshold Voltage                     | V <sub>IN(ON)</sub>  | Low-Side   | Applied between IN(UL), IN(VL),                                 | -    | -    | 0.8  | V    |
| OFF Threshold Voltage                    | V <sub>IN(OFF)</sub> |  | IN <sub>(WL)</sub> - COM <sub>(L)</sub>                         | 3.0  | -    | -    | V    |
| Resistance of Thermistor                 | R <sub>TH</sub>      | @ T <sub>TH</sub> = 25°C (Note                           | Fig. 6) (Note 7)  | -    | 50   | -    | kΩ   |
|  |                      | @ T <sub>TH</sub> = 100°C (Note                          | e Fig. 6) (Note 7)  | -    | 3.0  | -    | kΩ   |

# Electrical Characteristics (T<sub>J</sub> = 25°C, Unless Otherwise Specified)

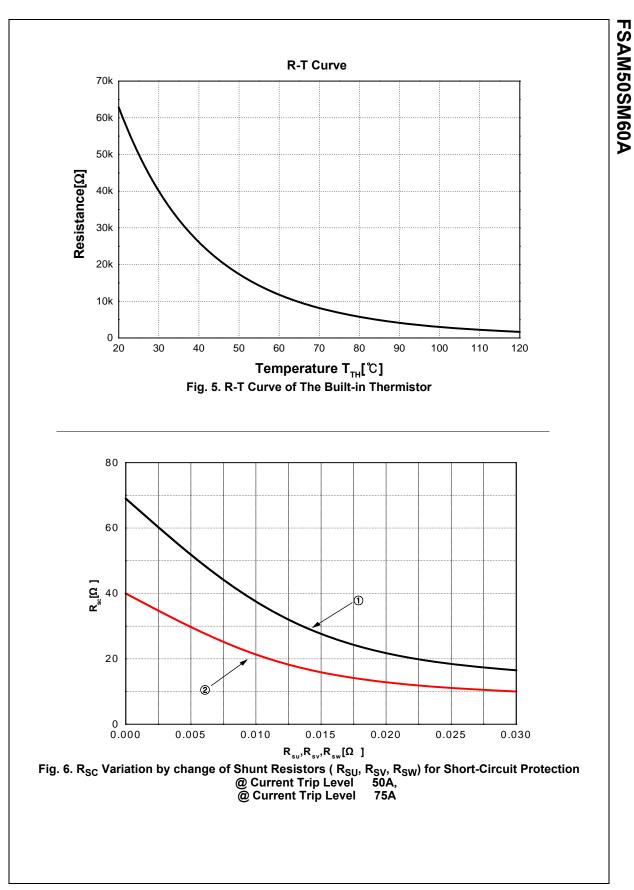
Note: 5. Short-circuit current protection is functioning only at the low-sides. It would be recommended that the value of the external sensing resistor ( $R_{SC}$ ) should be selected around 40  $\Omega$  in order to make the SC trip-level of about 75A at the shunt resistors ( $R_{SU}, R_{SV}, R_{SW}$ ) of  $\Omega$ . For the detailed information about the relationship between the external sensing resistor ( $R_{SC}$ ) and the shunt resistors ( $R_{SU}, R_{SV}, R_{SW}$ ), please see Fig. 6. 6. The fault-out pulse width t<sub>FCD</sub> depends on the capacitance value of C<sub>FOD</sub> according to the following approximate equation : C<sub>FOD</sub> = 18.3 x 10<sup>-6</sup> x t<sub>FOD</sub>[F] 7. T<sub>TH</sub> is the temperature of thermistor itself. To know case temperature ( $T_{C}$ ), please make the experiment considering your application.

# **Recommended Operating Conditions**

| 14.0.000                                  | Ourse had             | Condition  |      | Values   |      | Unit |
|---|-----------------------|--|------|----------|------|------|
| Item                                      | Symbol                | Condition  | Min. | Тур.     | Max. | Unit |
| Supply Voltage                            | V <sub>PN</sub>       | Applied between P - N <sub>U</sub> , N <sub>V</sub> , N <sub>W</sub>   | -    | 300      | 400  | V    |
| Control Supply Voltage                    | V <sub>CC</sub>       | Applied between $V_{CC(UH)}$ , $V_{CC(VH)}$ , $V_{CC(WH)}$ - $COM_{(H)}$ , $V_{CC(L)}$ - $COM_{(L)}$   | 13.5 | 15       | 16.5 | V    |
| High-side Bias Voltage                    | V <sub>BS</sub>       | Applied between $V_{B(U)}$ - $V_{S(U)}$ , $V_{B(V)}$ - $V_{S(V)}$ , $V_{B(W)}$ - $V_{S(W)}$  | 13.0 | 15       | 18.5 | V    |
| Blanking Time for Preventing<br>Arm-short | t <sub>dead</sub>     | For Each Input Signal  | 3.5  | -        | -    | us   |
| PWM Input Signal                          | f <sub>PWM</sub>      | T <sub>C</sub> ≤ 100°C, T <sub>J</sub> ≤ 125°C   | -    | 5        | -    | kHz  |
| Minimum Input Pulse Width                 | PW <sub>IN(OFF)</sub> | $\begin{array}{l} 200 \leq V_{PN} \leq 400V, \ 13.5 \leq V_{CC} \leq 16.5V, \\ 13.0 \leq V_{BS} \leq 18.5V, \ 0 \leq I_C \leq 100A, \\ -20 \leq T_J \leq 125^\circ C \\ V_{IN} = 5V \leftrightarrow 0V, \ \text{Inductive Load} \ (\text{Note 8}) \end{array}$               | 3    | -        | -    | us   |
| Input ON Threshold Voltage                | V <sub>IN(ON)</sub>   | $\begin{array}{l} \text{Applied between IN}_{(\text{UH})}, \text{IN}_{(\text{VH})}, \text{IN}_{(\text{WH})} \text{ - } \\ \text{COM}_{(\text{H})}, \text{IN}_{(\text{UL})}, \text{IN}_{(\text{VL})}, \text{IN}_{(\text{WL})} \text{ - } \text{COM}_{(\text{L})} \end{array}$ |      | 0 ~ 0.65 | 5    | V    |
| Input OFF Threshold Voltage               | V <sub>IN(OFF)</sub>  | $\begin{array}{l} \text{Applied between IN}_{(\text{UH})}, \text{IN}_{(\text{VH})}, \text{IN}_{(\text{WH})} \text{ - } \\ \text{COM}_{(\text{H})}, \text{IN}_{(\text{UL})}, \text{IN}_{(\text{VL})}, \text{IN}_{(\text{WL})} \text{ - } \text{COM}_{(\text{L})} \end{array}$ |      | 4 ~ 5.5  |      | V    |

Note: 8. SPM might not make response if the  $PW_{IN(OFF)}$  is less than the recommended minimum value.

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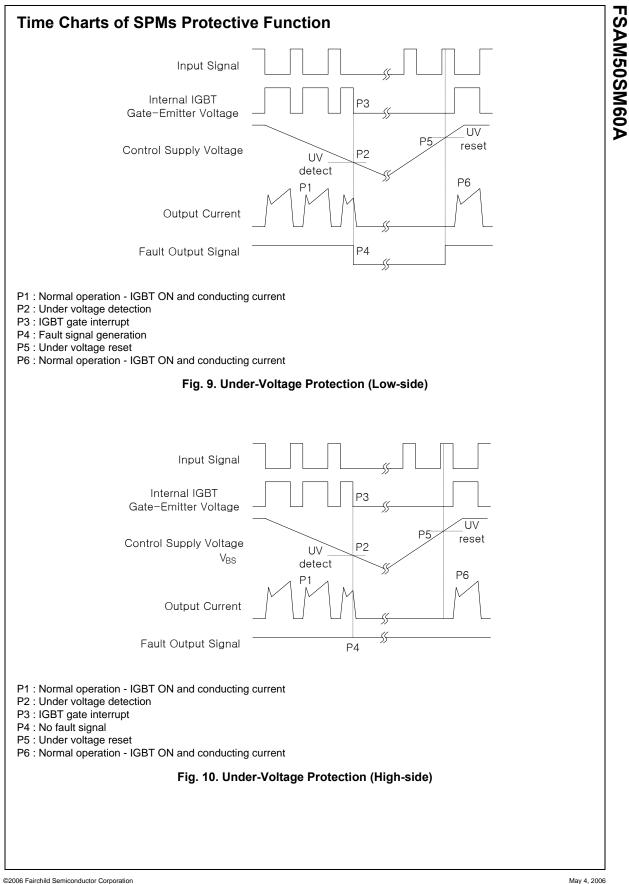
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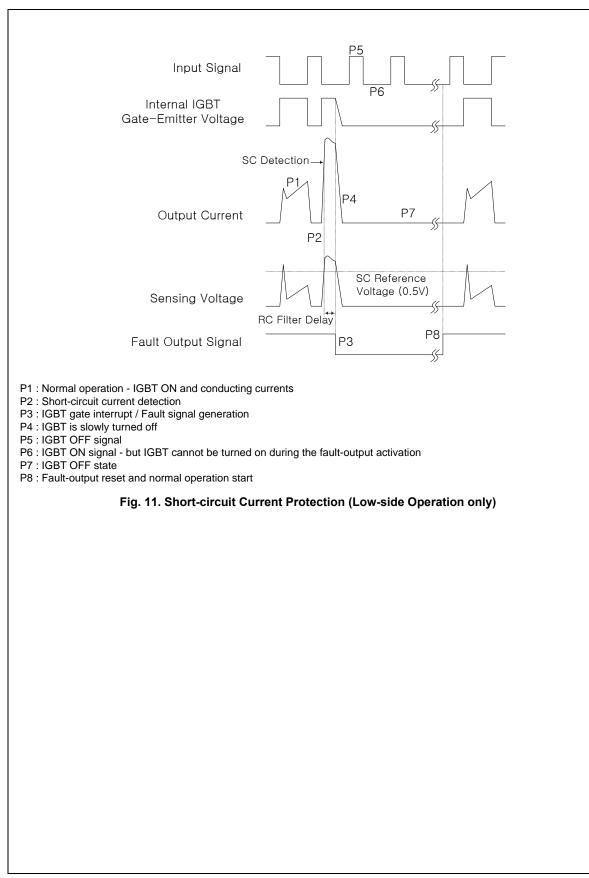
# **Mechanical Characteristics and Ratings** Limits Condition Item Units Min. Max. Тур. Mounting Torque Mounting Screw: M4 Recommended 10Kg•cm 8 10 12 Kg•cm (Note 9 and 10) Recommended 0.98N•m 0.78 0.98 1.17 N•m DBC Flatness Note Fig.7 0 +120 μm -Weight 32 -g (+) (+) Fig. 7. Flatness Measurement Position of The DBC Substrate Note: Do not make over torque or mounting screws. Much mounting torque may cause ceramic cracks and bolts and Al heat-fin destruction. Avoid one side tightening stress. Fig.8 shows the recommended torque order for mounting screws. Uneven mounting can cause the SPM ceramic substrate to be damaged. 2 Fig. 8. Mounting Screws Torque Order (1 $\rightarrow$ 2)

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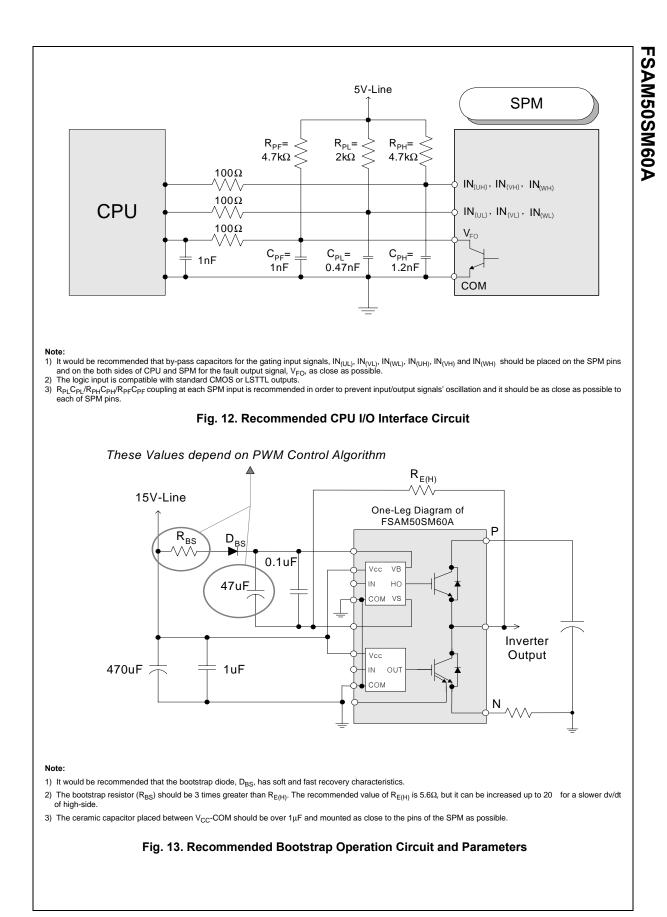
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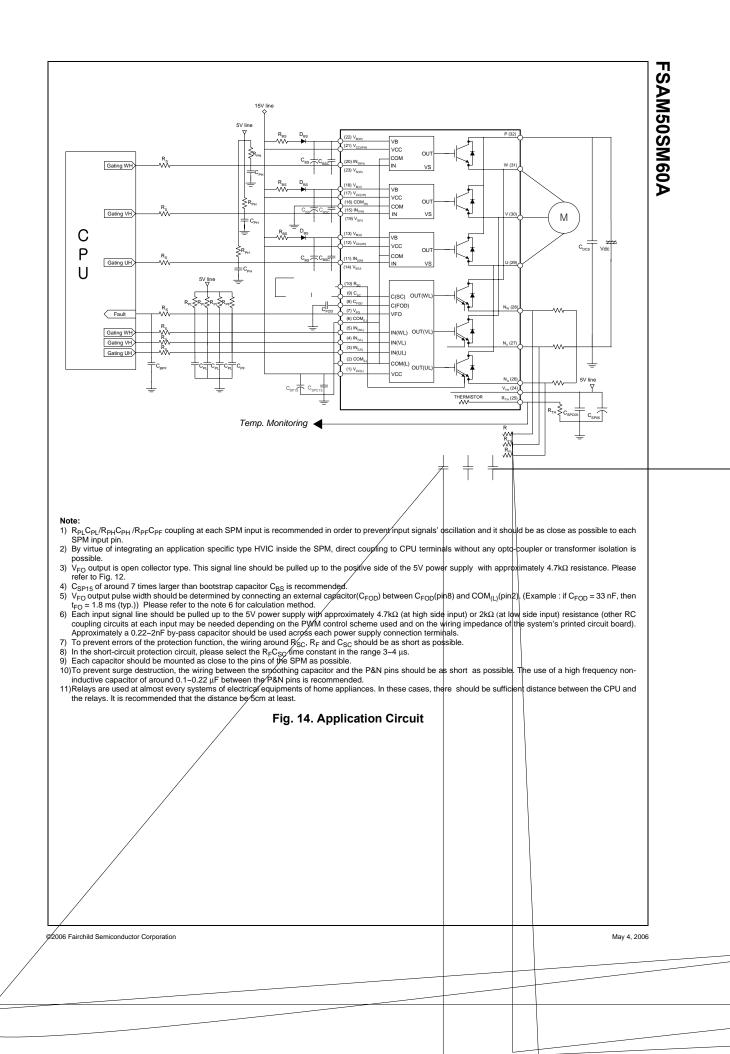


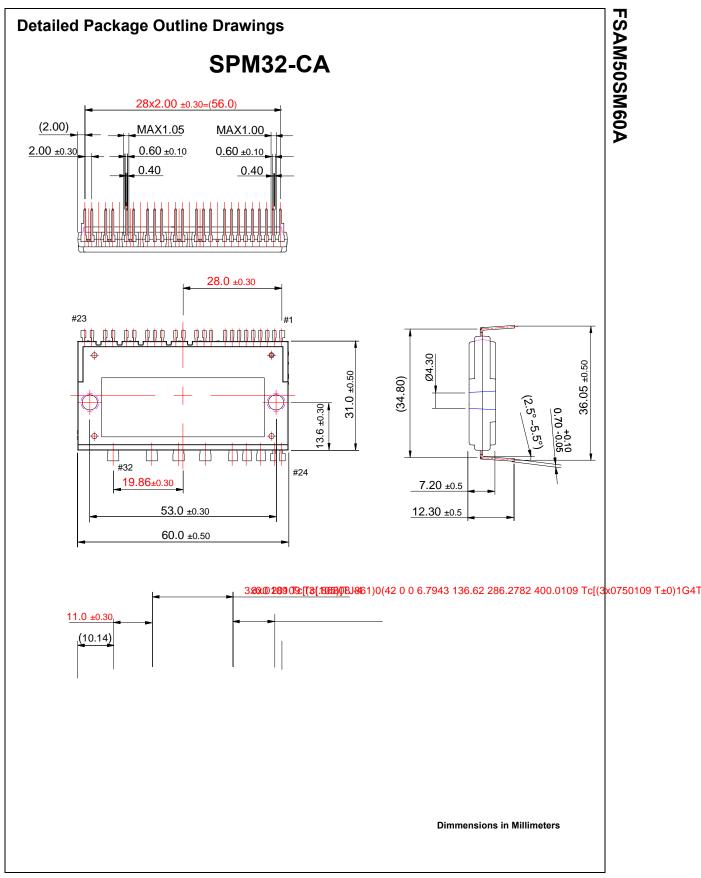
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| PowerTrench <sup>®</sup> | TCM™                   |
|--------------------------|------------------------|
| QFET <sup>®</sup>        | TinyBoost™             |
| QS™                      | TinyBuck™              |
| QT Optoelectronics™      | TinyPWM™               |
| Quiet Series™            | TinyPower™             |
| RapidConfigure™          | TinyLogic <sup>®</sup> |
| RapidConnect™            | TINYOPTO™              |
| µSerDes™                 | TruTranslation™        |
| ScalarPump™              | UHC™                   |
|                          |                        |
|                          |                        |

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